

Search Notes

Application/Control No.

10/628,237

Examiner

Nhan T. Tran

Applicant(s)/Patent under
Reexamination

SHIZUKUISHI, MAKOTO

Art Unit

2622

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (USPAT, PGPUB, JPO, EPO, DERWENT, IBM_TDB) text search - see search history printout	11/13/2006	NT
348/294-324 348/231.1-231.9 (text search - see search history printout)	11/16/2006	NT
text search class 257 - see search history printout	11/16/2006	NT
365/185.01-185.33 365/230.01-230.09 (text search - see search history printout)	11/22/2006	NT
Inventorship search - see search history printout	11/26/2003	NT